		APPLICATION	Page 1					
E	SCC		ower Schottky Bar nd STPS	rier Diodes bas	ed on types 1N5819U, 1N5822	U Appl. No.		
		Executive Member:	CNES		Date: 25/11/2024	368B		
Components (includi	ng series and families) submitted for Extension	of Qualification A	Approval:		1		
ESCC COMPONENT NO.	VARIANTS	RANGE OF CO	MPONENTS	BASED ON	TEST VEHICLE / S	COMPONENT SIMILAR		
5106/021	02, 03	LCC2B		1N5819U	510602102			
5106/020	01, 02	LCC2B		1N5822U	510602001			
5106/016	05, 06, 07, 11	TO-254, SMD0.5, SI	MD1	STPS20100	510601611			
5106/017	01, 02	SMD0.5		STPS1045				
5106/018 5106/019	02 03, 05	SMD1 TO254, SMD1		STPS6045 STPS40100				
5106/023	01, 02, 03, 04, 05, 06	SMD.5, TO-254AA		STPS80A150	0 510602301 510602303			
5106/024	01, 02, 03, 04	SMD.5, TO-254AA		STPS40A45	510602401	<u> </u>		
Component Ma STMicroelectronics	anufacturer	 Location of Ma 3, rue de Suisse BP4 	inufacturing Plant(Data of original qualification of	4		
STWICroelectronics		3, rue de Suisse BP4	4 199, 3504 1 Renr	les Cedex	Date of original qualification a Date: 01/09/2020	pprovai:		
					Certificate Ref No. 368			
		5		6		7		
ESCC Specifications		Deviations to LVT te	sting and Detail S	pecification	Qualification Extension Repor	t		
Maintenance of quali Generic: 5000	•	used:	- (averalised)	staile in Dav	reference and date:			
Generic: 5000	Issue: 10	No 🖂 Yes	(supply de 15)	etails in Box	STPS40A150 ID 33945004YV Full F4 DC 2209 STPS80A150 ID 33945004YW F4 Sg2 DC 2214			
Detail(s): 5106/01	6 Issue: 10	Deviation from curre	,		STPS80A45 ID 3652003ZB F	Full F4 DC 2221		
5106/01					1N5822 ID 3383800802 F4 S STPS20100 ID 33020001ZE			
5106/01 5106/01					1N5819 ID 33712001WV Full			
5106/02	0 5							
5106/02 5106/02								
5106/02								
		No 🖂 Yes	□ (Supply d	letails)				
						8		
Summary of procurer	ment or equivalent tes	t results during current va	alidity period in su	pport of this ap	plication (those to ESCC listed			
Project Name	Testing Leve	LAT	0	Date code	Quantity	y Delivered		
PID changes since st	art of qualification	9	Current PID V	arified by:	CNES	10		
None	an oi quaiilication	9	V Current FID	enneu by.	Name of Excutive Represe			
Minor*			Ref No: 0	Seneric: 80970	46 (generic) Rev 39 and Diodes			
	*Ducy vide details in he		Issue:		Date			
Major* 🛛	*Provide details in bo	X:	-	21/10/2024	Dale			
¹						11		
Current Manufacturin	g facilities surveyed b	y:	CNES		on 12	2/07/2023		
		(Nam	e of Executive Re	presentative)		(Date)		
Satisfactory:	Yes 🖂	No 🗆 Ex	plain					
			•					
Report Reference:	CR-Visite Juillet	2023						

	APPLICAT	ION FOR EXTE	INSION OF ESCC QUAL	IFICATI	ON APPROVAL	Page	2
ESCC	Component title:	Power Schott and STPS	ky Barrier Diodes based (on types	1N5819U, 1N5822U	Appl. I	No.
	Executive Member:	CNES		Date:	25/11/2024	3688	3
							12
Failure Analysis, DPA, NCCS ava	ailable: Yes	🛛 No	□ (Supply data)				
Ref. No's and purposes: 2CSTM403	3: RGA issue on 1N58 ⁻	19 (closed)					
The undersigned hereby certifies on behalt that the appropriate documentation has be (except as stated in box 15;) - that the report 	en evaluated; - that ful orts and data are availa	I compliance to able at the ESC	all ESCC requirements is C Executive and therefor	s evideno e applies	s on behalf of	erein.	13
Date: 26/11/2024				(S	L. FONTAIN		
Continuation of Boxes above:					Signa		14
Continuation of Boxes above.				2	Fonta	rique de ine Lya-Cnes 2024.11.26 28 +01'00'	14

[APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL						
	ESCC	Component title	e: Power Schottky Barrier Diodes base and STPS	d on types 1N5819U, 1N5822U	Appl. No.		
	15. 1	Executive Mem	nber: CNES	Date: 25/11/2024	368B		
Non com	pliance to ESCC requirements:				15		
No.:	Specification	_	Paragraoh	Non compliance			
Additional	I tasks required to achieve full co	mpliance for ESC	C qualification or rationale for acceptability	of	16		
Executive	Manager Disposition				17		
Application Action / R		No 🗆					
30 Date:	0/11/2024			B. Schade: Head of the Quality	Department		

	APPLICATI	ON FOR EXTENSION OF ESCC QUALIFIC	ATION API	PROVAL	Page 4	Ļ
ESCC	Component Title: Power Schottky Barrier Diodes based on type and STPS			9U, 1N5822U	Appl. No	D.
	Executive Member:	CNES	Date: 25/11/2024		368B	
ANNEX 1: LIST OF TESTS DONE TO SUPP	ORT EXTENSION	OF QUALIFICATION				18
Fests conducted in compliance with:						
 ESCC 5000 generic specification; or PID-TFD 	; Chart F4 (for ESC (for ESCC/QML p	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,				
Fests vehicle identification/description:						
Tests vehicle identification/description: STPS80A150CSGH 33945004YW SMD.5 (DC 2214) STPS40A150CHYG 33945004YV TO254A (DC 2209)	A F4 2242)	101B 3383800802 LCC2B F4 Sg1&3 (DC 101BF 33712001WV LCC2B F4 (DC 2311)				

Detail Specification reference: See box 5

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
	Mechanical shock		MIL-STD-750 TM2016	2209 2312	75	0	
	Vibration	\boxtimes	MIL-STD-750 TM2056	2209 2312	75	0	
cal Subgroup	Constant acceleration	\boxtimes	MIL-STD-750 TM2006	2209 2312	75	0	
	Seal Fine leak Gross leak	\boxtimes	MIL-STD-750 TM1071	2209 2312	75	0	
	Electrical Measurement		Intermediate and End- Point Electrical Measurements	2209 2312	75	0	
chani	External Visual	\boxtimes	ESCC Basic Spec 20500	2221 2312	75	0	
I/Mee	Thermal shock		MIL-STD-750 TM1056				Only applicable to axial lead glass diodes
Environmental/Mechanical Subgroup	Temperature Cycling	\boxtimes	MIL-STD-750 TM1051	2209 2312	75	0	
	Moisture Resistance	\boxtimes	MIL-STD-750 TM1021	2209 2312	75	0	
	Seal Fine leak Gross leak	\boxtimes	MIL-STD-750 TM1071	2209 2312	75	0	
	Electrical Measurement	\boxtimes	Intermediate and End- Point Electrical Measurements	2209 2312	75	0	
	External Visual	\boxtimes	ESCC Basic Spec 20500	2209 2312	75	0	
	Operating Life	\boxtimes	ESCC 5000 Para. 8.19	2209 2312	75	0	
Endurance Subgroup	Electrical Measurement	\boxtimes	Intermediate and End- Point Electrical Measurements	2209 2312	75	0	
Endu Subç	Seal Fine leak Gross leak	\boxtimes	MIL-STD-750 TM1071	2209 2312	75	0	
	External Visual Inspection	\boxtimes	ESCC Basic Spec 20500	2209 2312	75	0	
	Permanence of Marking		ESCC Basic Spec 24800				Not applicable for laser marking
up Up	Terminal Strength	\boxtimes	ESCC 5000 Para. 8.18	2209 2312	25	0	
Assembly Capability Subgroup	Internal Visual	\boxtimes	ESCC Basic Spec 20400	2209 2312	25	0	
As Ca Su	Bond Strength	\boxtimes	MIL-STD-750 TM 2037	2209 2312	15	0	
	Die Shear	\boxtimes	MIL-STD-750 TM 2017	2209 2312	15	0	

	APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL Page 5 Component title: Power Schottky Barrier Diodes based on types 1N5819U, 1N5822U Appl. No.								
(A)		ESLL		and STPS					Appl. No.
W ./~2	the state of the s		Exe	cutive Member: CNES		Da	te: 25/11/2	024	368B
a	Ch art Test wh F4			Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comm perf Comments o	ents if not formed. on Rejection
Additional Tests									
Ă									

						1			
		APPLICATI	ON FOR EXTENSION	ON OF ESCC QUALIFICA	TION APPROVAL	Page 7			
ES	SCC	Component title:	Power Schottky Ba and STPS	arrier Diodes based on typ	es 1N5819U, 1N5822U	Appl. No.			
		Executive Member:	CNES	Date	25/11/2024	368B			
NOTE	ES ON THE COMPL	ETION OF THE APP	LICATION FORM F	OR ESCC QUALIFICATIO	N EXTENSION APPROVA	L			
ENTRIES									
Form heading		e title of the componer e; - the certificate num			of the series, family; - the Ex	cecutive Member;			
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.								
Box 2; 3 and 4	As per QPL entry;	otherwise, an explan	ation of the changes	must be supplied.					
Box 5					revision letter, current at th ate of the application, see B				
Box 6	deviations this mu		In case the reference	ed specification in Box 5 h	particular deviations from to ave currently a different issu				
Box 7	Must reference the	e report(s) supplied in	support of the appli	cation.					
Box 8					l of which should already hav opriate table has been draw				
Box 9				last Extension of Qualifica or changes shall be clearly	ition, adequate details of suc marked.	ch evolution shall			
Box 10		nt PID issue status, o as possible to the rec			of verification of the currer	nt PID should be			
Box 11	practices, procedu	ires, material, etc. use	ed in manufacturing t	he components are as des	unexplained changes occur cribed in the PID. This surve ts findings shall be recorded	y shall be carried			
Box 12		s) (NCCS) occurred of			d Failure Analysis reports established corrective actio				
Box 13	Enter only the na Coordinator.	me of the Executive	Member (i.e., CNE	S, DLR, ESTEC, etc.) and	the signature of the respo	onsible Executive			
Box 14				es from 1 through 12. Iden f several boxes have to be	tify box affected and referen expanded.	nce the Box 14 in			
Box 15	Fill in Table as rec	quested.							
Box 16				Member to bring the subm n(s) to accept the noncom	itted data to a standard likel pliance.	y to be accepted			
Box 17					restrictions, modifications of representative for ESA, and				
Box 18	Fill in Table as rec	quested.							
Box 19			uding those of a cor	ifidential nature, shall be p	rovided.				
Box 20		nce with reference to Illy numbered. If relev		paragraph(s). To simplify	reference in Box 16 each	nonconformance			
Box 21				Member to bring the subm n(s) to accept the noncom	itted data to a standard likel pliance.	ly to be accepted			
Box 22	Additional Comme	ents.							